Se	arc	ch l	Voi	es	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/560,842	MATSUDA ET AL.
Examiner	Art Unit
Michael La Villa	1775

	SEAR	CHED	
Class	Subclass	Date	Examiner
428	626, 624, 632, 633, 653, 659	4/1/2007	ML
	681, 215		
_	336, 469		
428	457, 461	4/1/2007	ML
			-

INT	ERFERENC	CE SEARCH	ED
Class	Subclass	Date	Examiner
., .		 -	
	<u> </u>		

(INCLUDING	SEARCH	STRATEGY)
•		DATE	EXMR
	,		
Inventor Search		4/1/2007	ML
WEST SEARCH		4/1/2007	ML ·
		-	
·			
		:	
	•		